

Wet life Study of Nickel Hydrogen cells

Hari Vaidyanathan, Lockheed Martin -COMSAT Technical Services Gopalakrishna Rao , NASA Goddard Space Flight Center

NASA Aerospace Battery Workshop Huntsville, Alabama November 18-20, 2008

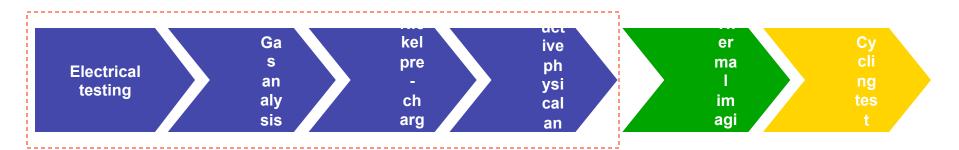
Background



- Unplanned launch delays often resulted in the use of batteries for NASA missions that exceed recommended wet life of 3-5 years
- HST and Space Station cells have wet life exceeding 8 years by refurbishment
- The impact of wet life of nickel hydrogen batteries on electrical performance, nickel pre-charge, gas content and degradation of the cell components are examined in this study that is sponsored by NASA-NESC



Technical Approach



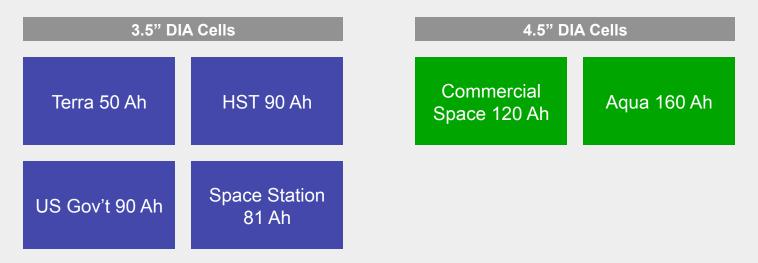
Cell Analysis

¹ DPA of nickel hydrogen cells with varying wet life

DPA



- Contract awarded to Lockheed Martin-COMSAT to perform the DPA in July 2007
- Selected 26 cells with 7-13 years of wet life from the satellites listed below:



All selected cells were in cold storage after ATP testing





Capacity not affected by storage as shown by:

dry + 8
dry + 8
dry + 8
And 12 year
year
year
wet life
wet life
wet life
Wet life
Wet life
Wet life
And 13 year
And 14 year
And 15 year
And 16 year
And 17 year
And 18 year
An

US Gov't 90 Ah

Commercial Space 120 Ah

Aqua 160 Ah

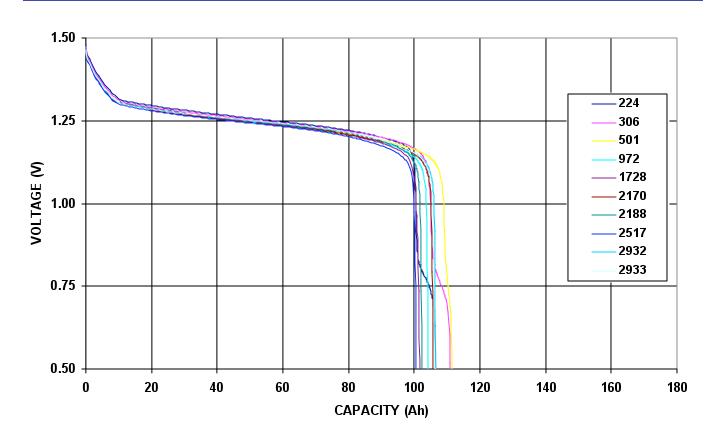
Performance Data

				10 °C CAP				
	Activation		to 1 V	2nd plateau	Resistor	Charge	Reversal	Voltage rise
	Date	S/N	(Ah)	(%)	(Ah)	Retention (%)	voltage	after 1 hr ¹
æ -C	Jan-1995	122(3.5")	66.9	NA	1.1	90.3	-0.28	0.095
Terra 50 Ah	Jan-1996	262(3.5")	64.7	NA	1.3	90.5	-0.29	0.084
	Oct-1994	224(3.5")	100.5	5.5	8.0	85.9	-1.43	0.134
_	Apr-1995	306(3.5")	104.9	5.5	2.3	87.6	-0.78	0.121
Space Station 81 Ah	Oct-1996	501(3.5")	109.0	2.2	1.1	84.7	-0.37	0.165
∞	Jul-1997	972(3.5")	103.6	NA	1.4	88.8	-0.31	0.110
ion	Dec-1998	1728(3.5")	100.6	NA	3.5	89.8	-0.33	0.091
Stat	Jan-2000	2170(3.5")	105.1	NA	1.2	88.9	-0.32	0.086
ø,	Oct-2001	2188(3.5")	101.7	NA	1.2	88.9	-0.32	0.134
рас	Aug-2002	2517(3.5")	100.0	NA	1.0	88.5	-0.3	0.095
S	Jun-2004	2932(3.5")	106.0	NA	1.4	88.6	-0.31	0.084
	Jun-2004	2933(3.5")	105.6	NA	1.1	88.7	-0.31	0.105
S ,t	Mar-1997	102(3.5")	103.3	NA	0.6	87.2	-0.38	0.080
US Gov't 90 Ah	Mar-1997	165(3.5")	102.0	NA	0.7	87.3	-0.36	0.078
	Aug-2000	605(3.5")	94.7	9.2	3.8	82.2	-1.52	0.061
HST 90 Ah	Aug-2000	718(3.5")	95.1	9.1	3.5	84.6	-1.51	0.080
	Apr-1997	1038(4.5")	153.2	NA	1.5	87.9	-0.41	0.063
_ 5	May-1997	1052(4.5"	147.9	4.3	7.2	86.7	-1.53	0.060
Commercial Space 120 Ah	Aug-1997	1238(4.5")	151.2	NA	1.7	87.3	-0.42	0.089
12	Aug-1999	1997(4.5")	139.9	NA	19.1	85.1	-1.23	0.072
ace m	Feb-2000	2204(4.5")	146.1	NA	1.3	87.3	-0.36	0.108
ပို့ ဗွ	Feb-2004	2749(4.5")	139.8	NA	1.0	87.3	-0.33	0.091
	Aug-2006	2925(4.5")	143.4	NA	3.1	87.1	-0.32	0.130
т П	Nov-1997	5(4.5")	200.8	NA	3.1	85.5	-0.39	0.018
Aqua 160 Ah	Nov-1997	89(4.5 ["])	200.8	NA	3.4	84.2	-0.4	0.016
4	Nov-1997	15(4.5")	193.6	NA	1.8	87.7	-0.33	0.015

¹ After resistor drain to 10 mV



10°C Discharge Profiles for ISS 81 Ah Cells



DPA Findings of All Cells

					POS	ITIVE	PL	ATES	3		N	IEG/	ATIV	E PL	ATE	S	SEP	ARA	TOF	RS	1		SC	REE	NS	1
ACTIVATION DATE	S/N		small blisters	large blisters	erupted blisters	rough surfaces	scratched surfaces	weak pliable plates	bent plate	holes in plate surface	wetted	pinholes	burnmarks	compression marks	dirty tabs	loose Pt	dirt on positive side	Pt on negative side	green staining	tears from blisters		wetted	burnmarks	melting at tab	dirty	discolored KOH
Oct-94	ISS 81 Ah S/N 224																									
Jan-95	EOS AM S/N 2-122																									
Mar-97	EPT 90-9 S/N 3-102 EPT																									
May-97	120Ah S/N 1052 EPT																									
Aug-97	120Ah S/N 1238 EOS PM	ı																								
Nov-97	S/N 1-5 ISS 81 Ah	H																								
Dec-98	S/N 1728 HST 90-3 S/N 10-																									
Aug-00 Oct-01	605 ISS 81 Ah S/N 2188	ľ																								
Jun-04	ISS 81 Ah S/N 2933																									

FREQUENCY KEY not present or neglible slight, found in less than 30% of modules moderate, between 30 and 70% extensive, greater than 70%



Voltage and gas analysis (mV)

	•			
Date	<u>S/N</u>	after 1 hr	after 24 hr	Gas on opening
Jan-1995	122	0.015	0.069	No gas
Oct-1994	224	0.029	0.077	No gas
Oct-1996	501	0.034	0.062	No gas
Jul-1997	972	0.028	0.080	No gas
Dec-1998	1728	0.022	0.075	No gas
Oct-2001	2188	0.027	0.083	No gas
Aug-2002	2517	0.022	0.077	No gas
Jun-2004	2933	0.025	0.089	No gas
Mar-1997	102	0.022	0.064	No gas
Aug-2000	605	0.022	0.031	No gas
May-1997	1052	0.017	0.122	No gas
Aug-1997	1238	0.020	0.116	No gas
Feb-2004	2749	0.022	0.159	No gas
Aug-2006	2925	0.025	0.159	No gas
Nov-1997	5	0.017	0.033	No gas

¹ After resistor drain to 2 mV



Electrolyte Distribution

Activation Date	S/N	Cell Size (Ah)	Pos.Plate (g/g plate)	Neg Plate (g/g plate)	Zircar (g/g sep)	Screen (g/g scrn)
Oct-94	224	81	0.14	0.04	1.28	0.08
Jan-95	2-122	50	0.14	0.05	1.42	0.12
Mar-97	3-102	90	0.14	0.04	1.38	0.07
May-97	1052	120	0.18	0.04	1.08	0.14
Nov-97	1-5	160	0.15	0.06	1.74	0.31
Dec-98	1728	81	0.14	0.03	1.35	0.20
Aug-00	10-605	90	0.15	0.05	1.31	0.05
Oct-01	2188	81	0.15	0.03	1.29	0.28
Jun-04	2933	81	0.13	0.03	1.24	0.15



Electrolyte Conc	entration				
Activation Date	S/N	Cell Size (Ah)	KOH Conc. (%)	K2CO3 Conc. (%)	cc/Ah
Oct-94	224	81	28.5	5.1	3.03
Jan-95	2-122	50	29.7	3.3	3.39
Mar-97	3-102	90	29.6	2.8	2.38
May-97	1052	120	27.1	4.7	2.82
Aug-97	1238	120	25.6	6.4	2.56
Nov-97	1-5	160	28.4	3.4	3.73
Dec-98	1728	81	28.1	3.9	3.21
Aug-00	10-605	90	30.7	2.9	2.92
Oct-01	2188	81	28.0	4.0	3.18
Jun-04	2933	81	28.8	4.0	2.99



Separator Characterization

Act.		Cell Size		verage	Resistiv	vity($^{\Omega}$ cm)	Absorbency
Date	S/N	(Ah)	Weight (g)	Thickness (mm)	single layer	double layer	(g KOH/g sep)
1992	virgin	3.5"	1.15	0.302	3.2	2.5	2.0
Oct-94	224	81	1.01	0.242	3.0	2.8	2.8
Jan-95	2-122	50	1.05	0.271	1.4	3.1	2.9
Mar-97	3-102	90	1.03	0.267	1.2	1.8	2.7
May-97	1052	120	1.94	0.258	3.2	2.6	3.1
Aug-97	1238	120	1.83	0.274	2.7	2.5	2.6
Nov-97	1-5	160	1.93	0.272	3.5	2.8	2.6
Dec-98	1728	81	1.11	0.268	3.2	2.3	2.5
Feb-00	2204	120	1.77	0.260	2.3	2.6	2.5
Aug-00	10-605	90	1.03	0.269	1.2	1.2	2.5
Oct-01	2188	81	1.03	0.248	2.6	3.7	2.5
Jun-04	2933	81	1.05	0.255	2.8	3.1	3.0



Positive Plate Analysis Comparison

Activation		Cell Ave. Weight	Cell Ave. Thickness	Ni(OH)2	Co(OH)2	Co(OH)2	Sinter	Substrate	POR	OSITY Plaque	LOAI	DING Total	UTILIZ Plate	ATION Cell
Date	Identification	(mm)	(mm)	(%,g)	(%,g)	(%,g)	(%,g)	(%,g)	<u>(%)</u>	(%)	(g/cc)	(g/cc)	(%)	(%)
1995	Virgin 50 AH	13.05	0.77	33.19	2.02	5.66	48.64	13.15	80.36	75.81	1.48	1.71	121.60	NA
	AM lot 2			4.33	0.26		6.34	1.71						
1997	Virgin HST	15.28	0.93	36.68	2.39	6.11	46.46	11.34	82.29	78.50	1.51	1.74	106.30	NA
	Lot 11			5.53	0.36		7.00	1.71						
Oct-94	S/N224		0.81	34.49 4.68	1.93	5.26	45.43 6.17	12.63 1.71	82.21	78.33	1.78	1.78	131.60	120.57
	ISS 81 Ah			4.00	0.26	6.17	0.17	1.71						
Jan-95	S/N 2-122	13.58	0.81	34.05	2.58	7.00	56.49	12.55	77.56	73.88	1.67	1.67	148.10	132.30
	50Ah			4.65	0.35		7.72	1.71						
Mar-97	S/N 3-102	15.65	0.95	39.69	2.43	5.72	50.45	10.87	80.48	77.23	1.80	1.80	113.90	118.95
	90 Ah			6.26	0.38		7.95	1.71						
Dec-98	S/N 1728	13.59	0.80	33.95	2.07	5.73	47.19	12.61	81.20	77.30	1.49	1.76	145.50	125.10
	ISS 81 Ah			4.61	0.28		6.41	1.71						
Aug-00	S/N 10-605	15.49	0.94	34.76	2.46	6.51	51.66	11.23	80.57	77.30	1.44	1.54	128.50	126.95
	HST			5.31	0.37		7.88	1.71						
Oct-01	S/N 188	13.44	0.81	33.89	2.20	6.17	46.24	12.75	82.00	78.10	1.43	1.73	153.40	129.90
	ISS 81 Ah			4.56	0.30		6.22	1.71						
Jun-04	S/N 2933	13.47	0.79	34.18	2.34	6.50	46.25	12.73	81.50	77.50	1.50	1.80	151.10	131.00
	ISS 81 Ah			4.60	0.32		6.23	1.71						
Nov-97	S/N 1-5	23.28	0.83	30.68	2.24	4.41	54.66	14.33	77.97	73.71	1.41	1.43	171.70	152.00
	160Ah			7.15	0.33		12.74	3.34						

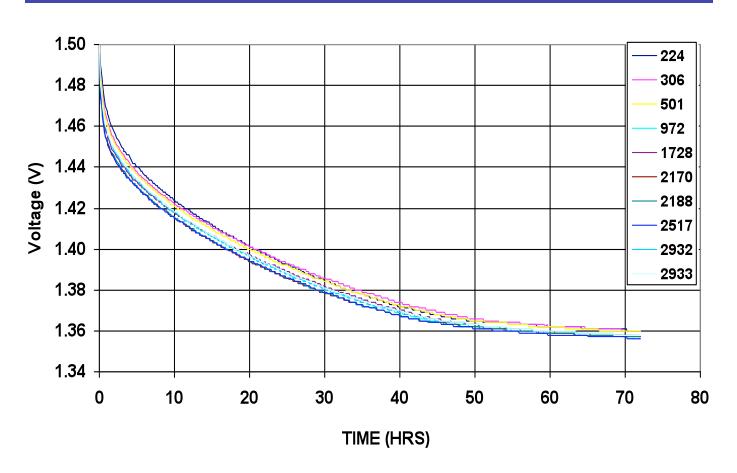


Positive Pre-charge

		CELL	CAPACITY	PRECHARGE CAPACITY				
		Rated	Actual 20 °C	Electrical	Chemical	Total		
<u>Activation</u>	CELL ID	Ah	Ah to 1.0 V	Ah	Ah	Ah		
Oct-94	224	81	90.6	0.1	8.3	8.4		
Jan-95	2-122	50	58.9	1.1	9.6	10.7		
Mar-97	3-102	90	91.5	0.5	8.3	8.8		
May-97	1052	120	130	0.2	14.4	14.6		
Aug-97	1238	120	134.7	0.9	17.9	18.8		
Nov-97	1-5	160	171.4	1.1	22.0	23.1		
Dec-98	1728	81	89.7	3.0	13.6	16.6		
Feb-00	2204	120	130.1	0.5	17.2	17.7		
Aug-00	10-605	90	82.4	0.2	9.7	9.9		
Oct-01	2188	81	90.8	2.7	10.0	12.7		
Jun-04	2933	81	94.4	1.9	14.4	16.3		

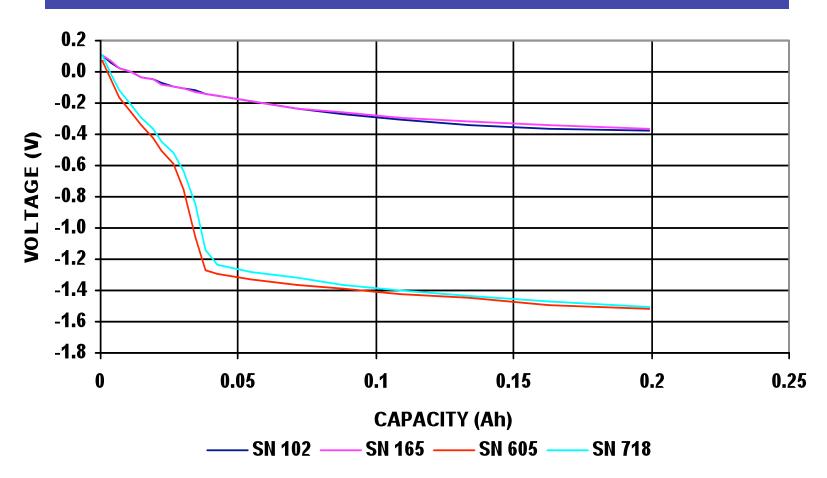


Charge Retention 72 Hour Open Circuit Stand, ISS cells



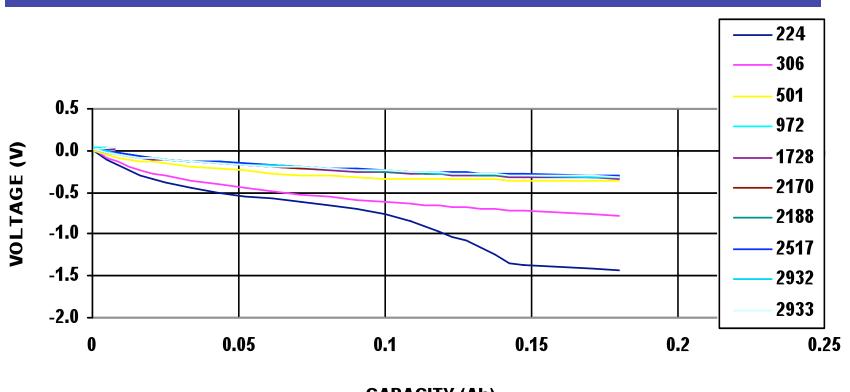


Cell Reversal for HST and US Gov't 90 Ah Cells





Cell Reversal for ISS Cells



CAPACITY (Ah)

Conclusions



- Cell capacity, charge retention, and voltage rise are not influenced by the wet life of cells
- Second voltage plateau occurs in cells with longer wet life
- There is no obvious impact of wet life on blistering of the positive plates
- Coefficient of positive material utilization is unchanged
- Wet life up to 13 years maintains nickel pre-charge and performance



Acknowledgements

The authors wish to acknowledge the financial support for NASA-NESC for this work. The authors are also grateful to SS/Loral for providing the Space Station cells.